


<b>Search Notes</b> 	<b>Application/Control No.</b> 10529067	<b>Applicant(s)/Patent Under Reexamination</b> WIEKHORST ET AL.
	<b>Examiner</b> Chau N Nguyen	<b>Art Unit</b> 2831

SEARCHED			
Class	Subclass	Date	Examiner
update	all	9/12/2008	CN
update	all	1/13/09	CN

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
see print out		9/12/2008	CN
see print out		1/13/09	CN

--	--